


<b>Search Notes</b>  	<b>Application/Control No.</b>  10591107	<b>Applicant(s)/Patent Under Reexamination</b>  LIU, ENHUI
	<b>Examiner</b>  Joey Bednash	<b>Art Unit</b>  2461

SEARCHED			
Class	Subclass	Date	Examiner
370	389	6/30/2010	Joey Bednash
709	223	6/30/2010	Joey Bednash

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in eDAN	6/30/2010	Joey Bednash
EAST search history attached	6/30/2010	Joey Bednash
Inventor search in eDAN	1/28/2011	Joey Bednash
EAST search history attached	1/28/2011	Joey Bednash

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Joey Bednash/ Examiner.Art Unit 2461	
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